

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Appl. No.	:	TBD
Applicant	:	Shinya Adachi
Filed	:	Herewith
Title	:	"DIGITAL MAP POSITION INFORMATION COMMUNICATION METHOD, PROGRAM FOR EXECUTING THE SAME, PROGRAM PRODUCT THEREFOR, SYSTEM, THEREFOR, AND APPARATUS THEREFOR
Confirmation No.	:	TBD
TC/A.U.	:	TBD
Examiner	:	TBD
International App. No.	:	PCT/JP2004/011492
International Flg. Date	:	August 4, 2004
Customer No.	:	052054
Docket No.	:	39564

INFORMATION DISCLOSURE STATEMENT

Mail Stop PCT
Commissioner for Patents
P.O. Box 1450
Alexandria, Va. 22313-1450

Sir/Madam:

In accordance with Rule 56, applicant is aware of the publications listed in the International Search Report (ISR, copy enclosed) and in the enclosed copy of Patent Office Form 1449.

Copies of the publications cited in the International Search Report are not enclosed as they were previously forwarded by the International Bureau, however, copies of the publications cited in the specification are enclosed.

Express Mail Label No.: EV739047192US

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Application No.: TBD
January 25, 2006
Page 2 of 2

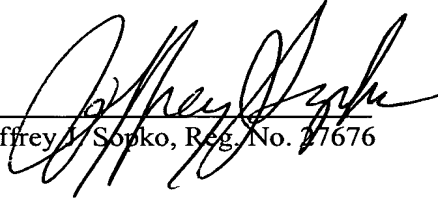
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If there are any fees required by this communication, please charge such fees to our
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Respectfully submitted,

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January 24, 2006

Form PTO-1449	U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE	ATTY. DOCKET NO. 39564	SERIAL NO. 107565899 TBD
INFORMATION DISCLOSURE CITATION BY APPLICANT (USE SEVERAL SHEETS IF NECESSARY)		APPLICANT: Shinya Adachi	
		FILING DATE: Herewith	GROUP ART UNIT: TBD

U.S. PATENT DOCUMENTS

Examiner Initial		Document No.	Date	Name	Class	Subclass	Filing Date If Appropriate
	A						
	B						
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	K						

FOREIGN PATENT DOCUMENTS

		Document No.	Date	Country	Class	Subclass	Translation
	L	2001-41757	02/2001	JAPAN			Cited in Specification-English Abstract
	M	2001-66146	03/2001	JAPAN			Cited in Specification-English Abstract
	N	2002-162241	06/2002	JAPAN			Cited on ISR
	P	2002-228468	08/2002	JAPAN			Cited on ISR
	Q	2002-328033	11/2002	JAPAN			Cited on ISR
	R	2003-23357	01/2003	JAPAN			Cited in Specification-English Abstract

OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)

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Examiner:

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